

# Multi-MHz Magnetics Off and On Chip

Prof. Alex Hanson

University of Texas at Austin

2024 Power Electronics and Energy Conversion Workshop at Sandia National Laboratories

1

## The MHz Barrier

Power electronics switching frequencies are approaching or have surpassed 1 MHz at power levels <1 W and >100 kW

There are a bunch of things that *don't work* or that we *don't know* (well) about designing magnetics past a few MHz

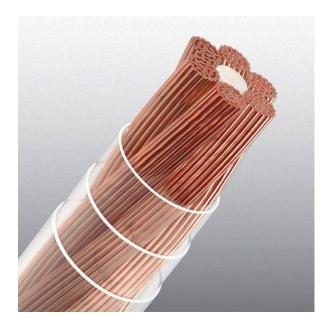
- What core materials are good? [1] What metrics constitute "good"? [2]
- How should core loss and full component losses be measured? [3-4]
- How can ac copper loss be mitigated? [5-10]
- What do we do about dimensional resonance? [11]
- When should air core components be used? [2,12]
- What can be achieved with IC integration?

### Managing copper loss in the MHz regime

Braided parallel strands of wire (litz wire) with  $D_{strand}$  < Skin Depth can suppress the skin and proximity effects at hundreds of kHz

48 AWG is already very expensive and only good up to a few MHz.

#### Litz will not save us in the MHz regime!





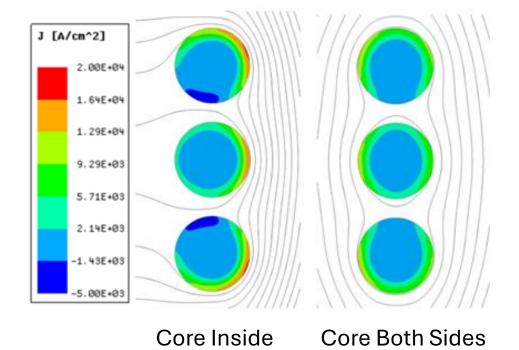
### Where does current actually flow at HF?

High-frequency current flows within a single skin depth of the surface of a conductor where the H field is strongest.

The terms "skin effect" and "proximity effect" are deeply misleading.

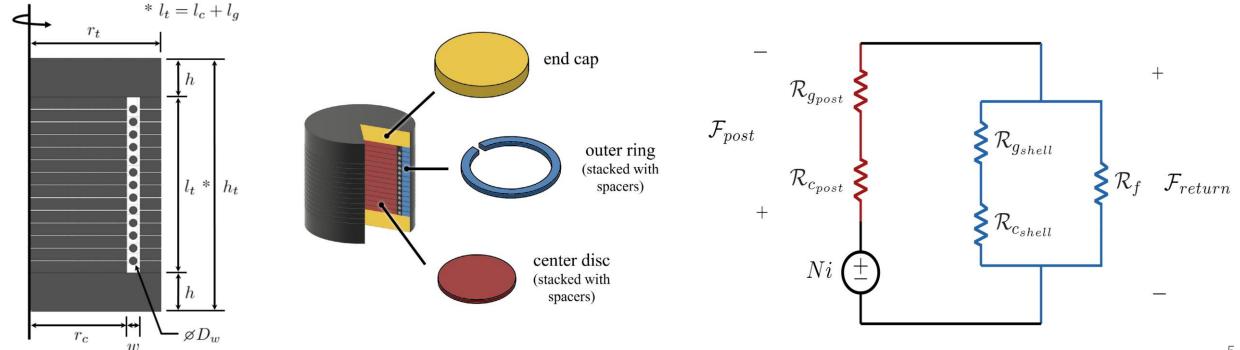
- They both come from solving the magnetic diffusion equation. Separating them is artificial
- The true "skin effect" is almost never encountered. Current only flows evenly over the entire surface in the case of a circular conductor in isolation.
- The "proximity effect" has very little to do with proximity. Conductors being close to each other does not necessarily increase the proximity effect

#### Just remember that current crowds near strong H fields.

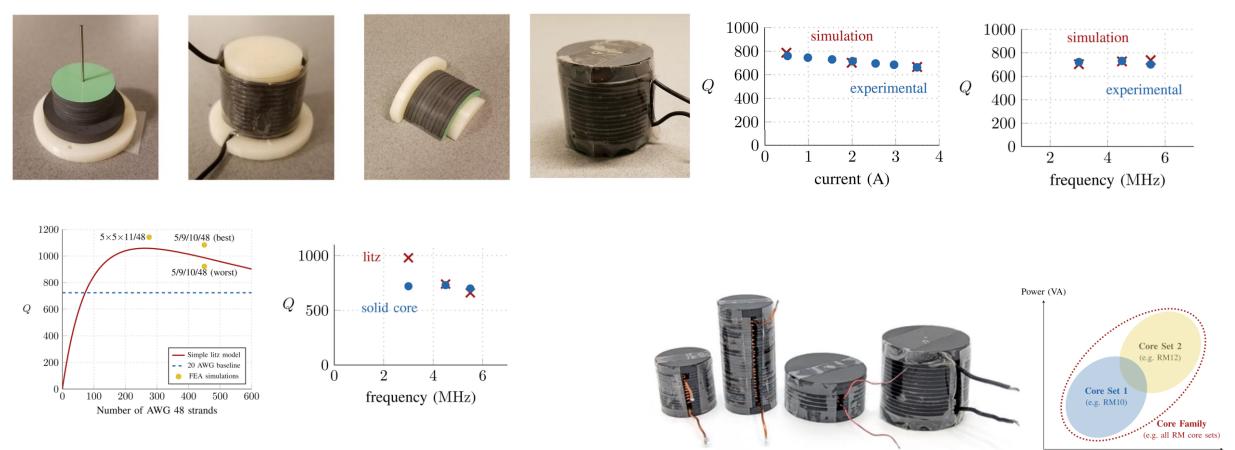


#### Double sided conduction in inductors

Consider a pot-core inductor with single-layer winding and the H fields adjacent to the conductors. The H field up the inner side of the winding is  $H_{inside} = \mathcal{F}_{post}/l_t$ The H field down the outer side of the winding is  $H_{outside} = \mathcal{F}_{return}/l_t$  $\Rightarrow$  To achieve  $H_{inside} = H_{outside}$ , we must engineer  $\mathcal{F}_{post} = \mathcal{F}_{return}$ 



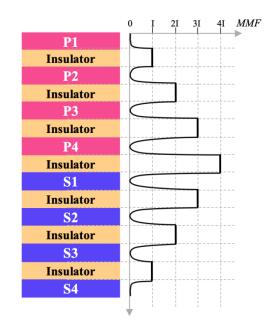
#### Inductor test results



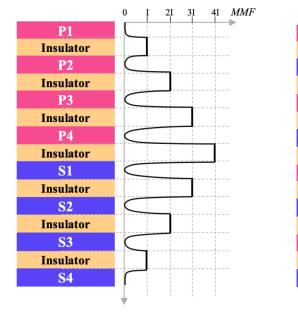
Prototypes achieved **quality factors of ~800** with solid-core wire and ~1000 with litz (but not at all frequencies!)

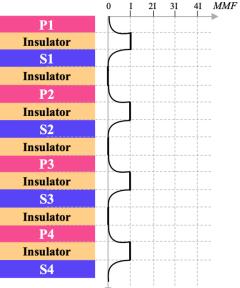
Designing for double-sided conduction revealed a **modular** inductor structure capable of covering a wider application space with fewer piece types to manufacture

Impedance (V/A)



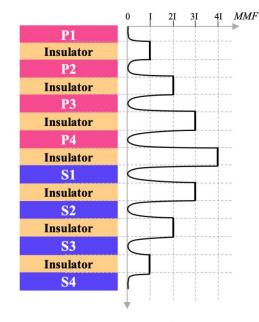
(a) Non-Interleaved Winding





(a) Non-Interleaved Winding

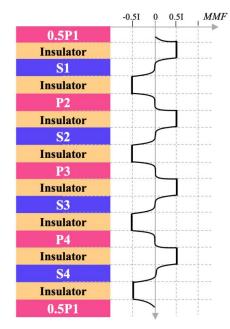
(b) Traditional Interleaved Winding



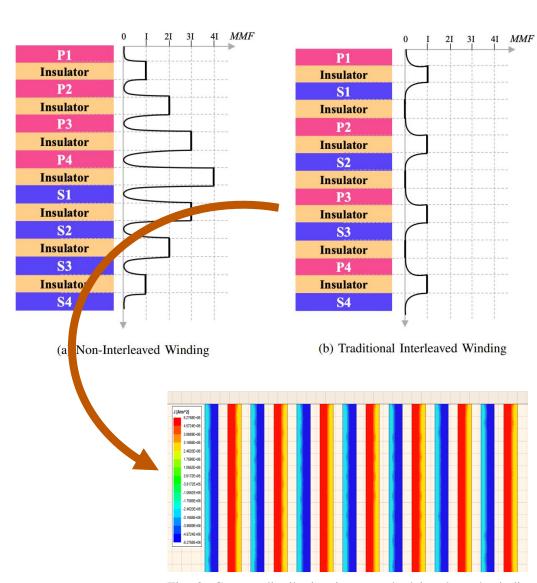
	0	I	21	31	4I	MMF
P1			1			->
Insulator						
<b>S1</b>	$\int$					-
Insulator						-
P2		-		1		_
Insulator						-
<b>S2</b>	(					2
Insulator						-
P3						-
Insulator						_
<b>S3</b>	ſ					-
Insulator						-
P4						-
Insulator						-
<b>S4</b>	ſ	1	1			
	÷	1			i.	

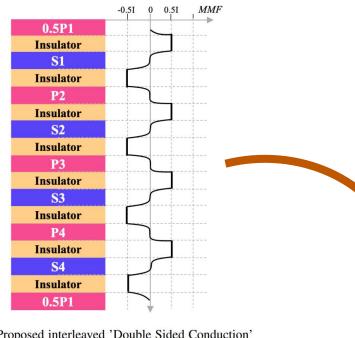
(a) Non-Interleaved Winding

(b) Traditional Interleaved Winding

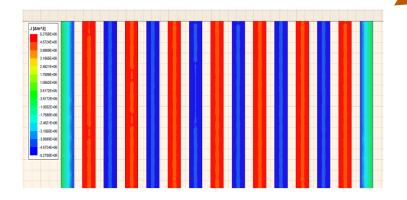


(c) Proposed interleaved 'Double Sided Conduction' winding





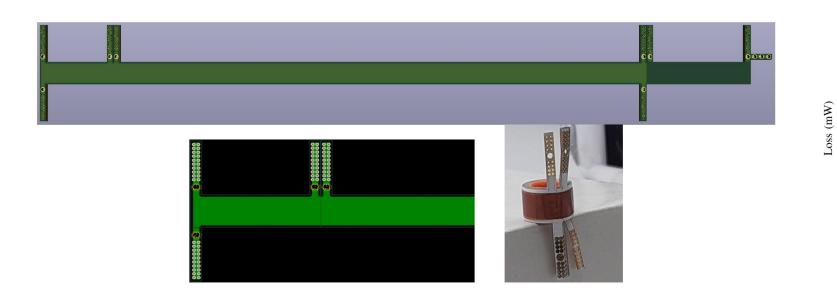
(c) Proposed interleaved 'Double Sided Conduction' winding

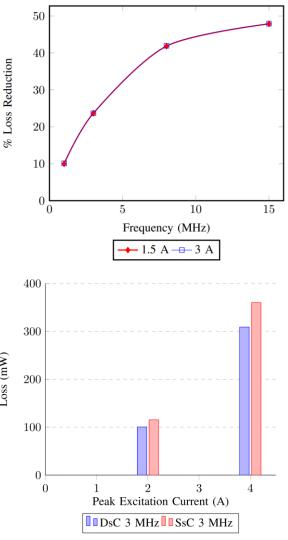


#### Transformer test results

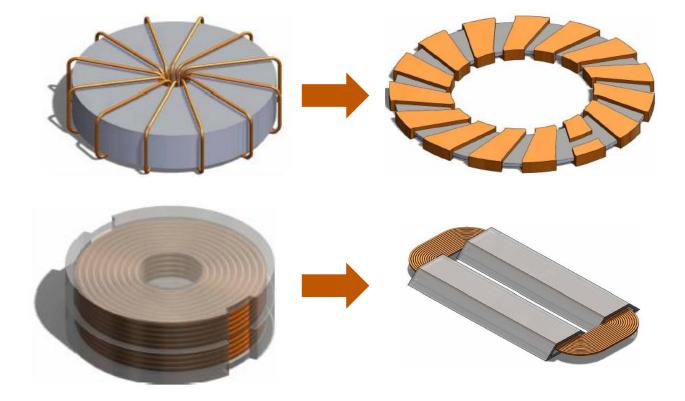
Copper loss reduces by 50% when skin depth limited.

Experimentally built with flexible PCB Experimentally achieved ~20% loss reduction as expected at 3 MHz





### MHz Opportunity - Integration



Shell-Type

Core-Type

- Enables massive integrated processing
- Lower interconnect losses
- More conducive for high-volume fabrication

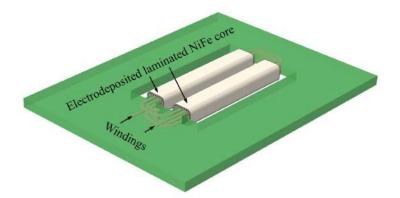
This is one of my favorite examples of a successful **collaboration** 

- Prof. Alex Hanson, UT Austin power electronics
- Prof. Jean Anne Incorvia, UT Austin magnetic materials
- Dr. Jianliang Lin, Southwest Research Institute oxide sputtering

With funding from a UT Austin/SwRI seed grant and a NASA NSTGRO fellowship

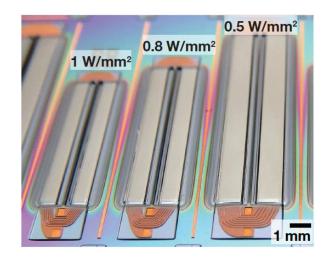
#### Fast growth or low loss?

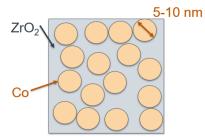
Metallic Fast electroplating More eddy currents



NiFe core material

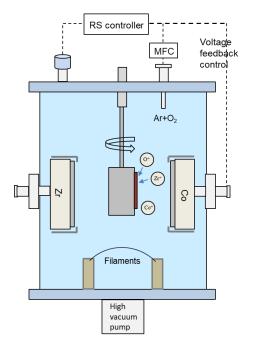
#### Ceramic/Composite Slow sputtering High resistivity

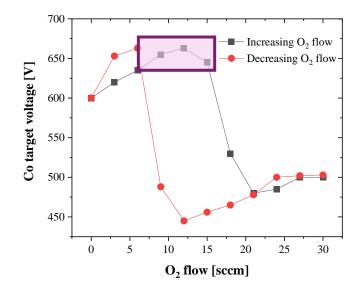




CoZrO core material

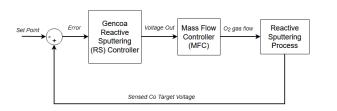
#### Improving sputter rate





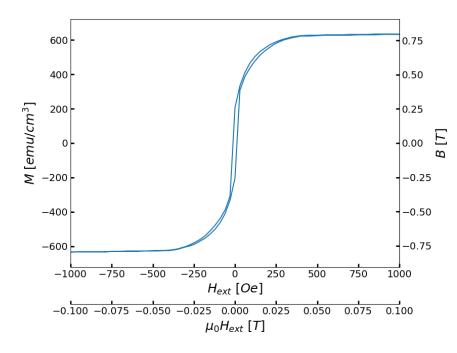
Study	Material	Deposition Rate (nm/min)		
Kumar et al. [1]	Со	4.5		
Cronin et al. [2]	CoZrTa	20.8		
Harburg et al. [3]	CoZrO	20		
Our System	CoZrO	125		







#### Performance is not sacrificed



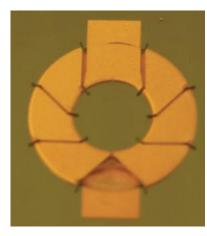
	Our Sample	Harburg et al. [1]
Co (%)	78.2	58.4
Zr (%)	9.3	7.1
O (%)	12.5	34.5
B <sub>sat</sub> (T)	0.74	1.2
μ	57	80-100
H <sub>c</sub> (Oe)	11.5	20

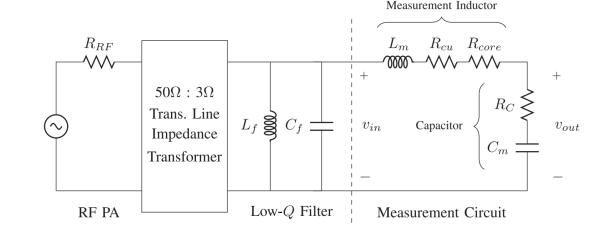
- High Saturation > 0.6 T (plenty)
- High Permeability ( $\mu$ ) ~ 60 (plenty)
- Low Coercivity  $(H_c) < 20 \text{ Oe}$

These are all *static* metrics. CoZrO really shines at high frequency

### We will shortly test components at 10-50 MHz

- Components with CoZrO demonstrated excellent performance almost a decade ago. We aim to demonstrate similar or improved performance with materials that were more quickly grown
- Near-complete core-type (toroid, U-core) component process flow
- Resonant techniques for measuring loss at 10-50 MHz





#### References

[1] A.J. Hanson, J.A. Belk, S. Lim, C.R. Sullivan and D.J. Perreault, "Measurements and Performance Factor Comparisons of Magnetic Materials at High Frequency," in IEEE Transactions on Power Electronics, vol. 31, no. 11, pp. 7909-7925, Nov. 2016, doi: 10.1109/TPEL.2015.2514084.

[2] A. J. Hanson, "Opportunities in Magnetic Materials for High-Frequency Power Conversion," in MRS Communications, Aug 2022, doi: https://doi.org/10.1557/s43579-022-00225-1

[3] M. Solomentsev, A. J. Hanson, "A Resonant Approach to Transformer Loss Characterization," 2022 IEEE Applied Power Electronics Conference and Exposition (APEC), Houston, TX, USA, 2022, pp. 596-603, doi: 10.1109/APEC43599.2022.9773516.

[4] A. Brown, M. Solomentsev, A. J. Hanson, "Parallel Resonant Loss Characterization of high Frequency Magnetic Components," IEEE Journal of Emerging and Selected Topics in Power Electronics (Accepted 2024)

[5] R.S. Yang, A.J. Hanson, B.A. Reese, C.R. Sullivan, D.J. Perreault, "A Low-Loss Inductor Structure and Design Guidelines for High-Frequency Applications," in IEEE Transactions on Power Electronics, vol. 34, no. 10, pp. 9993-10005, Oct. 2019, doi: 10.1109/TPEL.2019.2892397.

[6] R.S. Yang, A.J. Hanson, C.R. Sullivan, D.J. Perreault, "Design Flexibility of a Modular Low-Loss High-Frequency Inductor Structure," in IEEE Transactions on Power Electronics, vol. 36, no. 11, pp. 13013-13024, Nov. 2021, doi: 10.1109/TPEL.2021.3076774.

[7] M. Solomentsev and A. J. Hanson, "Modeling Current Distribution Within Conductors and Between Parallel Conductors in High-Frequency Magnetics," in IEEE Open Journal of Power Electronics, vol. 3, pp. 635-650, October 2022, doi: 10.1109/OJPEL.2022.3212903.

[8] O. Okeke, M. Solomentsev, A. J. Hanson, "Double-Sided Conduction: A Loss-Reduction Technique for High Frequency Transformers," 2022 IEEE Applied Power Electronics Conference and Exposition (APEC), Houston, TX, USA, 2022, pp. 611-618, doi: 10.1109/APEC43599.2022.9773592.

[9] A. Nguyen, A. Phanse, M. Solomentsev, and A. J. Hanson, "A Low-Leakage, Low-Loss Magnetic Transformer Structure for High-Frequency Applications," 2022 24th European Conference on Power Electronics and Applications (EPE'22 ECCE Europe), Hanover, Germany, 2022, pp. 1-11.

[10] A. Brown, M. Solomentsev, C. Fu, O. Okeke, and A. J. Hanson, "Double Sided Conduction in N:1 Transformers," 2024 IEEE Applied Power Electronics Conference (APEC), Long Beach, CA, USA, 2024, pp. 884-889, doi: 10.1109/APEC48139.2024.10509440.

[11] T. Guillod, W. V. R. Roberts and C. R. Sullivan, "Characterization and Impact of Large-Signal Dielectric Properties in MnZn Ferrites," 2024 IEEE Applied Power Electronics Conference and Exposition (APEC), Long Beach, CA, USA, 2024, pp. 384-390, doi: 10.1109/APEC48139.2024.10509366.

[12] M. Solomentsev and A. J. Hanson, "At What Frequencies Should Air-Core Magnetics Be Used?," in IEEE Transactions on Power Electronics, vol. 38, no. 3, pp. 3546-3558, March 2023, doi: 10.1109/TPEL.2022.3222993.